

PowerMOS transistor**BUK426-100A
BUK426-100B**

T-39-11

GENERAL DESCRIPTION

N-channel enhancement mode field-effect power transistor in a plastic full pack envelope.

The device is intended for use in Switched Mode Power Supplies (SMPS), motor control, welding, DC/DC and AC/DC converters, and in general purpose switching applications.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	MAX.	UNIT
V_{DS}	Drain-source voltage	-100A 100	-100B 100	V
I_D	Drain current (DC)	20	19	A
P_{tot}	Total power dissipation	45	45	W
$R_{DS(ON)}$	Drain-source on-state resistance	0.057	0.065	Ω

MECHANICAL DATA

Dimensions in mm

Net Mass: 5.5 g

Pinning:

1 = Gate

2 = Drain

3 = Source

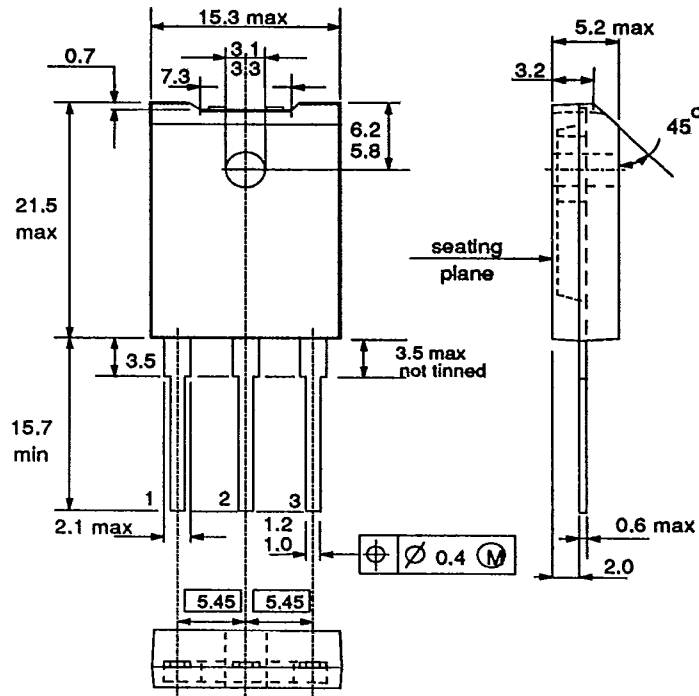
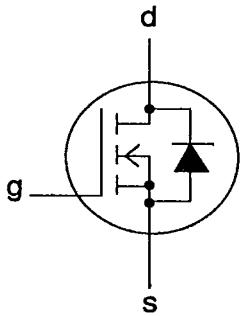


Fig.1 SOT-199; The seating plane is electrically isolated from all terminals.

Notes

1. Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
2. Accessories supplied on request: refer to Mounting instructions for F-pack envelopes.

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RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{DS}	Drain-source voltage	-	-	100	V
V_{DGR}	Drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$	-	100	V
$\pm V_{GS}$	Gate-source voltage	-	-	30	V
I_D	Drain current (DC)	$T_{hs} = 25^\circ\text{C}$	-	-100A	A
I_D	Drain current (DC)	$T_{hs} = 100^\circ\text{C}$	-	20	A
I_{DM}	Drain current (pulse peak value)	$T_{hs} = 25^\circ\text{C}$	-	12	A
			-	80	A
P_{tot}	Total power dissipation	$T_{hs} = 25^\circ\text{C}$	-	45	W
T_{stg}	Storage temperature	-	-55	150	$^\circ\text{C}$
T_j	Junction Temperature	-	-	150	$^\circ\text{C}$

THERMAL RESISTANCES

From junction to heatsink	with heatsink compound	$R_{th\ j-hs} = 2.8 \text{ K/W}$
From junction to ambient	-	$R_{th\ ja} = 35 \text{ K/W}$

STATIC CHARACTERISTICS

 $T_{hs} = 25^\circ\text{C}$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_D = 0.25 \text{ mA}$	100	-	-	V
$V_{GS(TO)}$	Gate threshold voltage	$V_{DS} = V_{GS}; I_D = 1 \text{ mA}$	2.1	3.0	4.0	V
I_{DSS}	Zero gate voltage drain current	$V_{DS} = 100 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25^\circ\text{C}$	-	1	10	μA
I_{DSS}	Zero gate voltage drain current	$V_{DS} = 100 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 125^\circ\text{C}$	-	0.1	1.0	mA
I_{GSS}	Gate source leakage current	$V_{GS} = \pm 30 \text{ V}; V_{DS} = 0 \text{ V}$	-	10	100	nA
$R_{DS(ON)}$	Drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 15 \text{ A}$	-	0.052	0.057	Ω
		BUK426-100A	-	0.06	0.065	Ω
		BUK426-100B	-			

DYNAMIC CHARACTERISTICS

 $T_{hs} = 25^\circ\text{C}$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
g_{fs}	Forward transconductance	$V_{DS} = 25 \text{ V}; I_D = 15 \text{ A}$	12	16	-	S
C_{iss}	Input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}$	-	1500	2000	pF
C_{oss}	Output capacitance		-	450	600	pF
C_{rss}	Feedback capacitance		-	130	200	pF
t_{don}	Turn-on delay time	$V_{DD} = 30 \text{ V}; I_D = 3 \text{ A}; V_{GS} = 10 \text{ V}; R_{gen} = 50 \Omega; R_{GS} = 50 \Omega$	-	20	30	ns
t_r	Turn-on rise time		-	40	60	ns
t_{doff}	Turn-off delay time		-	150	200	ns
t_f	Turn-off fall time		-	65	85	ns
L_d	Internal drain inductance	Measured from drain lead 6 mm from package to centre of die	-	5	-	nH
L_s	Internal source inductance	Measured from source lead 6 mm from package to source bond pad	-	12.5	-	nH

ISOLATION

 $T_{hs} = 25^\circ\text{C}$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V_{isol}	Repetitive peak voltage from all three terminals to external heatsink	R.H. $\leq 65\%$; clean and dustfree	-	-	2500	V
C_{isol}	Capacitance from T2 to external heatsink	$f = 1 \text{ MHz}$	-	22	-	pF

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Philips Components

PowerMOS transistor

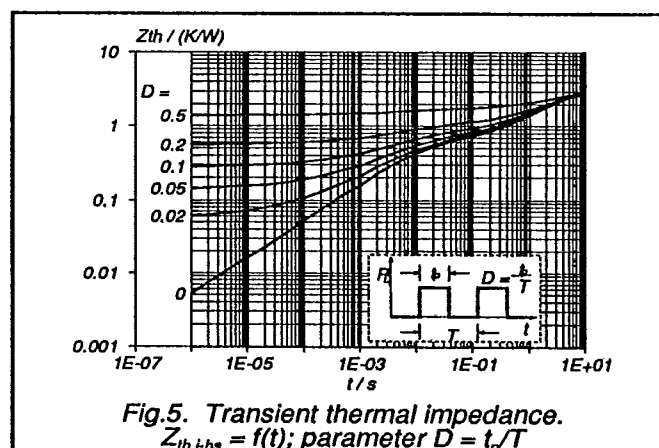
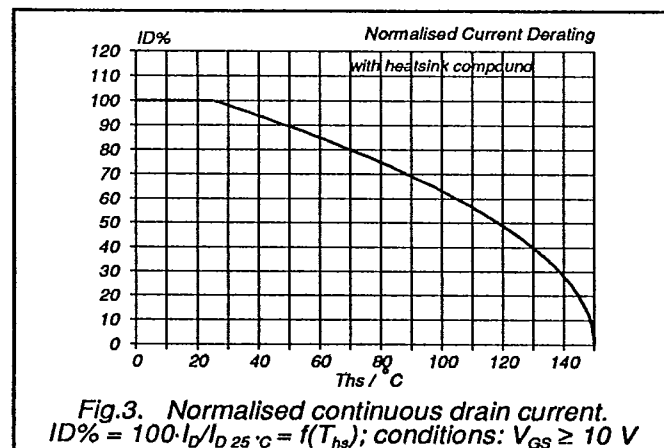
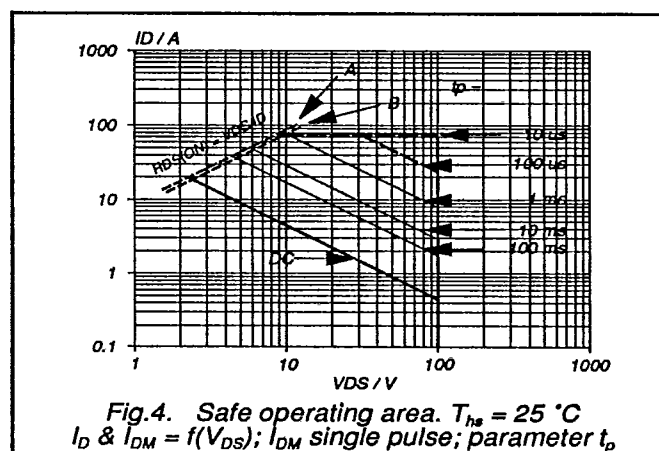
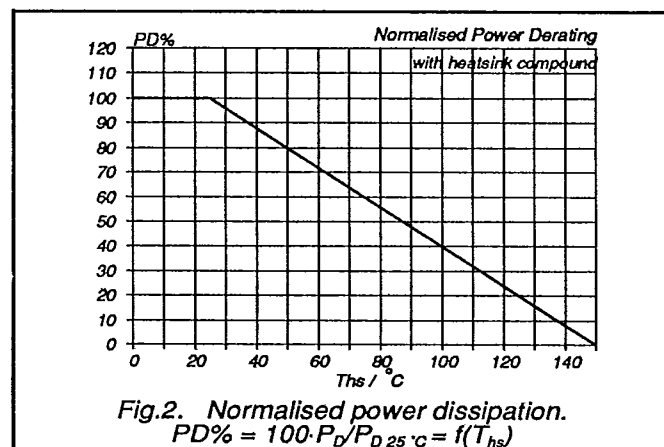
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REVERSE DIODE RATINGS AND CHARACTERISTICS

T_{hs} = 25 °C unless otherwise specified

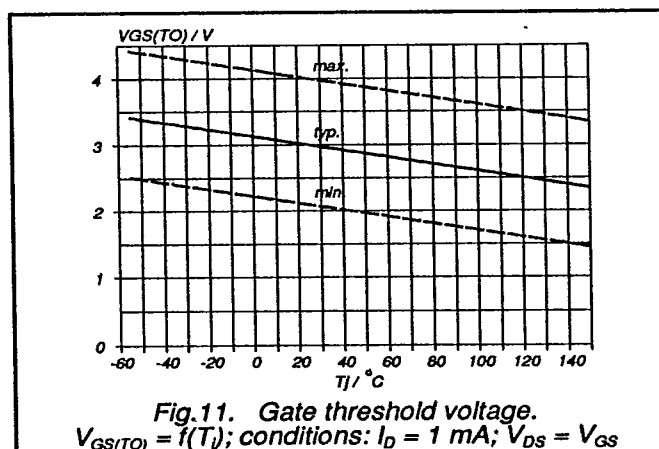
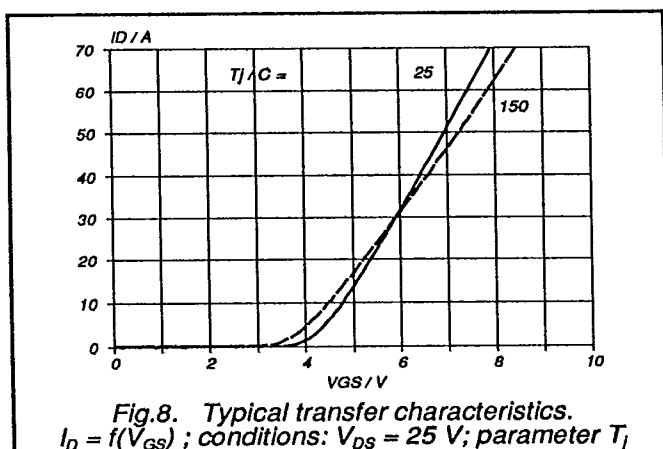
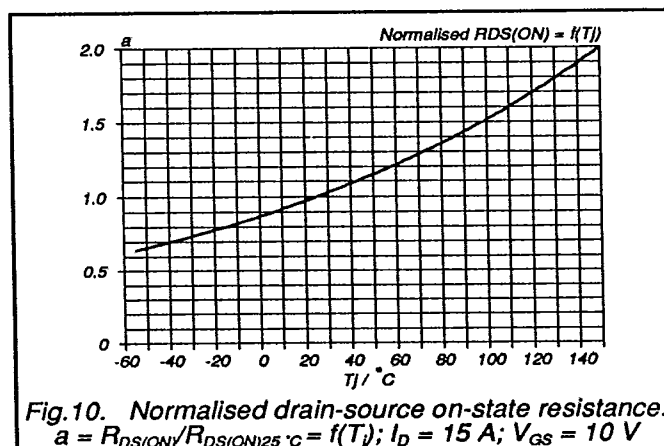
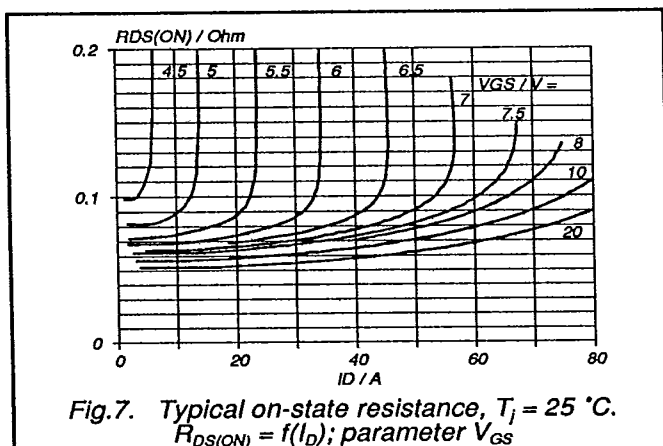
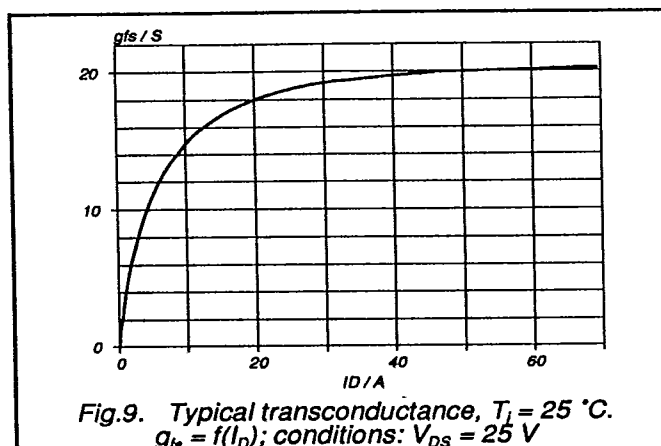
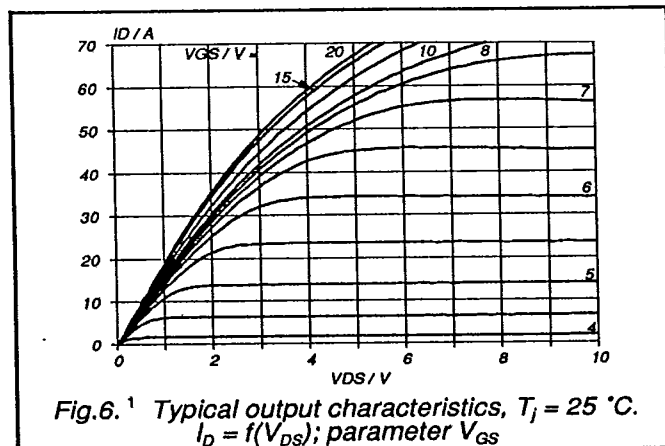
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I_{DR}	Continuous reverse drain current	-	-	-	20	A
I_{DRM}	Pulsed reverse drain current	-	-	-	80	A
V_{SD}	Diode forward voltage	$I_F = 20 \text{ A}; V_{GS} = 0 \text{ V}$	-	1.3	1.7	V
t_{rr}	Reverse recovery time	$I_F = 20 \text{ A}; -di_F/dt = 100 \text{ A}/\mu\text{s}; V_{GS} = 0 \text{ V}; V_R = 30 \text{ V}$	-	500	-	ns
Q_{rr}	Reverse recovery charge	$I_F = 20 \text{ A}; -di_F/dt = 100 \text{ A}/\mu\text{s}; V_{GS} = 0 \text{ V}; V_R = 30 \text{ V}$	-	2.9	-	μC



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